

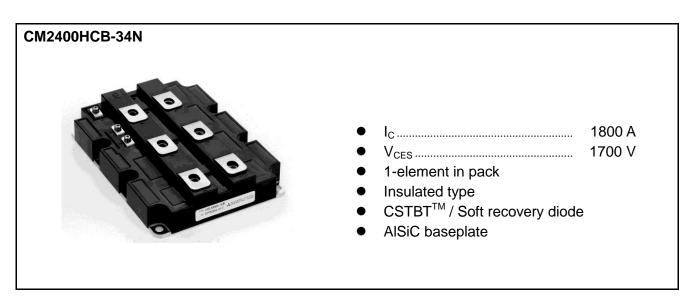
< High Voltage Insulated Gate Bipolar Transistor: HVIGBT >

CM1800HCB-34N

HIGH POWER SWITHCHING USE

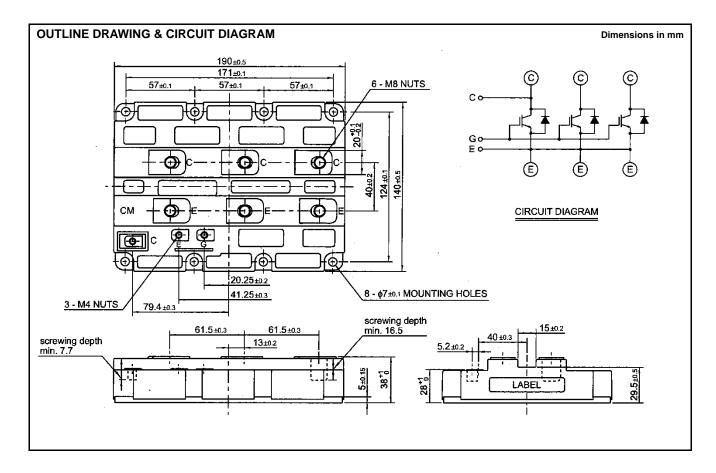
INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules



APPLICATION

Traction drives, High Reliability Converters / Inverters, DC choppers



MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
V _{CES}	Collector-emitter voltage	V _{GE} = 0V, T _j = 25 °C	1700	V
V_{GES}	Gate-emitter voltage	$V_{CE} = 0V, T_j = 25 ^{\circ}C$	± 20	V
Ic		DC, $T_c = 80 ^{\circ}\text{C}$	1800	Α
I _{CRM}	Collector current	Pulse (Note 1)	3600	Α
I _E	Cmitter current (Note 2)	DC	1800	Α
I _{ERM}	Emitter current (NOTE 2)	Pulse (Note 1)	3600	Α
P _{tot}	Maximum power dissipation (Note 3)	T _c = 25 °C, IGBT part	13800	W
V _{iso}	Isolation voltage	RMS, sinusoidal, f = 60Hz, t = 1min.	4000	V
Tj	Junction temperature		-40 ~ +150	°C
T _{jop}	Operating temperature		-40 ~ +125	°C
T _{stg}	Storage temperature		− 40 ~ + 125	°C
t _{pSC}	Maximum short circuit pulse width	$V_{CC} = 1000V, V_{CE} \le V_{CES}, V_{GE} = 15V, T_j = 125^{\circ}C$	10	μs

ELECTRICAL CHARACTERISTICS

Cumbal	Item	Conditions		Limits		Unit	
Symbol		Conditions		Min	Тур	Max	Unit
I _{CES}	Callacter outoff comment	V _{CF} = V _{CFS} , V _{GF} = 0 V	$T_j = 25 ^{\circ}C$	_	_	8	mΑ
ICES	Collector cutoff current	VCE = VCES, VGE = U V	T _j = 125 °C	_	6.0	16	IIIA
$V_{GE(th)}$	Gate-emitter threshold voltage	$V_{CE} = 10 \text{ V}, I_{C} = 180 \text{ mA}, T_{j} = 25 ^{\circ}\text{C}$		5.5	6.5	7.5	V
I _{GES}	Gate leakage current	$V_{GE} = V_{GES}$, $V_{CE} = 0V$, $T_j = 25$ °C		-0.5	_	0.5	μΑ
C _{ies}	Input capacitance	\ -10\\\\ -0\\ f-100\\	V 40.V.V 0.V.C 400.U.E		352	_	nF
C _{oes}	Output capacitance	$V_{CE} = 10 \text{ V}, V_{GE} = 0 \text{ V}, f = 100 \text{ kHz}$ $T_j = 25 \text{ °C}$		_	19.2	_	nF
C _{res}	Reverse transfer capacitance			_	5.6	_	nF
Q_G	Total gate charge	$V_{CC} = 900 \text{ V}, I_C = 1800 \text{ A}, V_{GE} = \pm 15 \text{ V}$	·	_	24.4	_	μC
V _{CEsat}	Collector-emitter saturation voltage	I _C = 1800 A (Note 4)	$T_j = 25 ^{\circ}C$	_	2.00	2.60	V
V CEsat		V _{GE} = 15 V	T _j = 125 °C	_	2.20		- V
t _{d(on)}	Turn-on delay time	$V_{CC} = 900 \text{ V}, I_{C} = 1800 \text{ A}$		_	_	1.50	μs
t _r	Turn-on rise time	$V_{GE} = \pm 15 \text{ V}, R_{G(on)} = 0.9 \Omega$ $T_i = 125 \text{ °C}, L_s = 80 \text{ nH}$			_	0.60	μs
E _{on(10%)}	Turn-on switching energy (Note 5)	Inductive load		_	0.56	_	J
$t_{d(off)}$	Turn-off delay time	V _{CC} = 900 V, I _C = 1800 A		_	_	3.00	μs
t _f	Turn-off fall time	$V_{GE} = \pm 15 \text{ V}, R_{G(off)} = 1.3 \Omega$			_	0.60	μs
E _{off(10%)}	Turn-off switching energy (Note 5)	T _j = 125 °C, L _s = 80 nH Inductive load		_	0.50	_	J
.,	(Note 2)	I _E = 1800 A ^(Note 4)	T _j = 25 °C	_	2.10	2.90	.,
V _{EC}	Emitter-collector voltage (Note 2)	V _{GE} = 0 V	T _j = 125 °C	_	1.75	_	V
t _{rr}	Reverse recovery time (Note 2)	V _{CC} = 900 V, I _E = 1800 A		_	_	1.50	μs
Q _{rr}	Reverse recovery charge (Note 2)	V_{GE} = ±15 V, $R_{G(on)}$ = 0.9 Ω T_{j} = 125 °C, L_{s} = 80 nH Inductive load			700	_	μC
E _{rec(10%)}	Reverse recovery energy (Note 2) (Note 5)			_	0.44		J

THERMAL CHARACTERISTICS

Symbol	ltem	Conditions	Limits			Lloit
			Min	Тур	Max	Unit
$R_{th(j-c)Q}$	Thermal resistance	Junction to Case, IGBT part		_	9.0	K/kW
$R_{th(j-c)D}$		Junction to Case, FWDi part		_	13.0	K/kW
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, λ _{grease} = 1W/m•k, D _(c-s) = 100μm	_	7.0	_	K/kW

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CM1800HCB-34N

HIGH POWER SWITHCHING USE INSULATED TYPE

4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
		Conditions	Min	Тур	Max	Unit
M_t	Mounting torque	M8 : Main terminals screw	7.0		13.0	N⋅m
Ms		M6: Mounting screw	3.0		6.0	N⋅m
M_t		M4 : Auxiliary terminals screw	1.0	I	2.0	N⋅m
m	Mass		_	1.5	l	kg
CTI	Comparative tracking index		600	1	I	_
da	Clearance		19.5	I	l	mm
ds	Creepage distance		32.0	I	l	mm
L _{P CE}	Parasitic stray inductance		_	10.0		nΗ
R _{CC'+EE'}	Internal lead resistance	T _C = 25 °C	_	0.18	_	mΩ

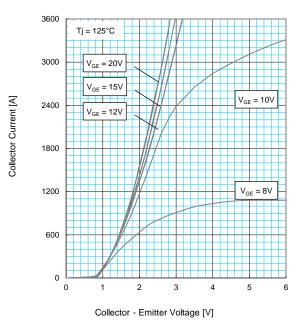
Note1. Pulse width and repetition rate should be such that junction temperature (T_j) does not exceed T_{jopmax} rating.

- 2. The symbols represent characteristics of the anti-parallel, emitter to collector free-wheel diode (FWD_i).
- 3. Junction temperature (T_j) should not exceed T_{jmax} rating (150°C).
- 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.
- 5. $E_{on(10\%)}$ / $E_{off(10\%)}$ / $E_{rec(10\%)}$ are the integral of 0.1 V_{CE} x 0.1 I_C x dt.

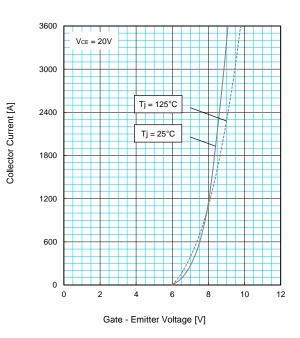
PERFORMANCE CURVES

INSULATED TYPE

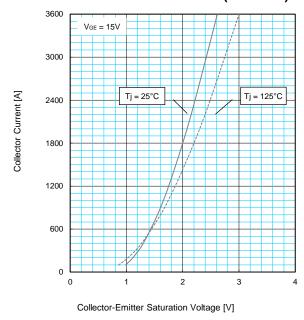
OUTPUT CHARACTERISTICS (TYPICAL)



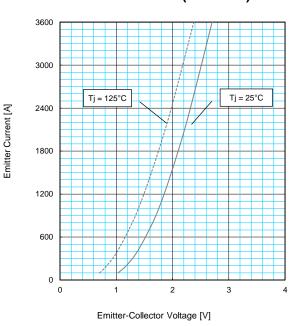
TRANSFER CHARACTERISTICS (TYPICAL)



COLLECTOR-EMITTER SATURATION VOLTAGE CHARACTERISTICS (TYPICAL)



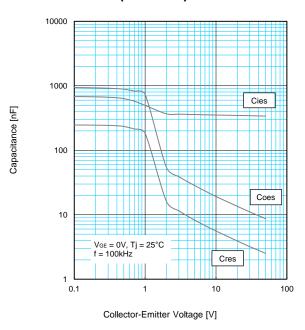
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



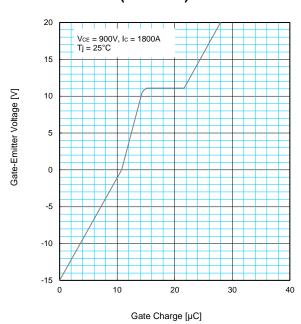
PERFORMANCE CURVES

INSULATED TYPE

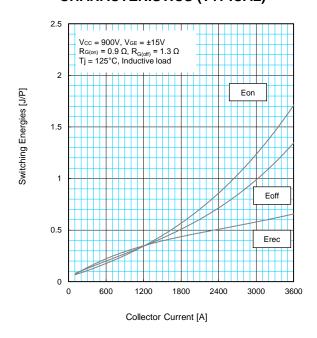
CAPACITANCE CHARACTERISTICS (TYPICAL)



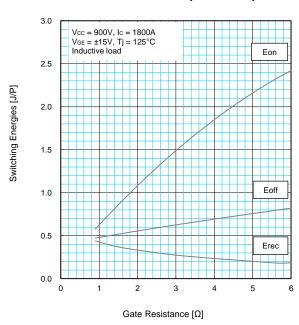
GATE CHARGE CHARACTERISTICS (TYPICAL)



HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



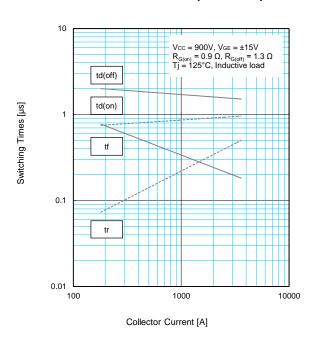
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



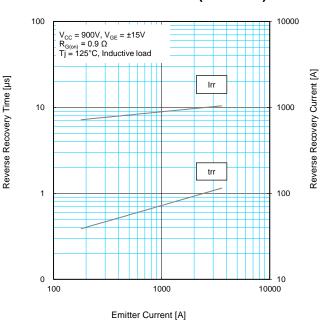
PERFORMANCE CURVES

INSULATED TYPE

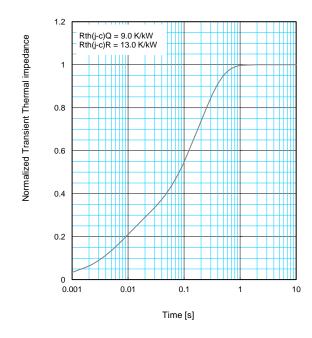
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



FREE-WHEEL DIODE REVERSE RECOVERY CHARACTERISTICS (TYPICAL)



TRANSIENT THERMAL IMPEDANCE CHARACTERISTICS



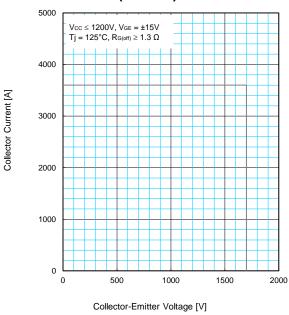
$$Z_{th(j-c)}(t) = \sum_{i=1}^{n} R_{i} \left\{ 1 - exp^{\left(-\frac{t}{\tau_{i}}\right)} \right\}$$

Collector Current [A]

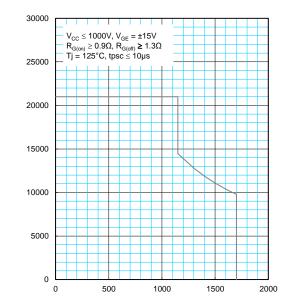
PERFORMANCE CURVES

INSULATED TYPE

REVERSE BIAS SAFE OPERATING AREA (RBSOA)

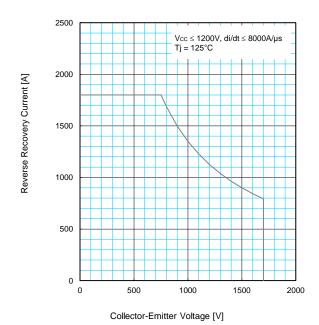


SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)



Collector-Emitter Voltage [V]

FREE-WHEEL DIODE REVERSE RECOVERY SAFE OPERATING AREA (RRSOA)



4th-Version HVIGBT (High Voltage Insulated Gate Bipolar Transistor) Modules

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